

Notice of References Cited	Application/Control No. 10/585,372		Applicant(s)/Patent Under Reexamination BLEUKX ET AL.	
	Examiner Ephrem Alemu		Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0125414	06-2006	Oda et al.	315/276
*	B	US-2005/0258778	11-2005	Chen, Wei	315/209.00R
*	C	US-2003/0107332	06-2003	Newman et al.	315/307
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	P					
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NON-PATENT DOCUMENTS

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